JETIR.ORG

ISSN: 2349-5162 | ESTD Year: 2014 | Monthly Issue



JOURNAL OF EMERGING TECHNOLOGIES AND INNOVATIVE RESEARCH (JETIR)

An International Scholarly Open Access, Peer-reviewed, Refereed Journal

Ref No: JETIR / Vol 5 / Issue 8 / 170

Confirmation Letter

To,

Dr. Pranay Parashar

Published in : Volume 5 | Issue 8 | 2018-08-16



Subject: Publication of paper at International Journal of Emerging Technologies and Innovative Research.

Dear Author,

With Greetings we are informing you that your paper has been successfully published in the International Journal of Emerging Technologies and Innovative Research (ISSN: 2349-5162). Following are the details regarding the published paper.

About JETIR : An International Scholarly Open Access Journal, Peer-Reviewed, Refereed

> Journal Impact Factor Calculate by Google Scholar and Semantic Scholar AI-Powered Research Tool, Multidisciplinary, Monthly, Multilanguage Journal Indexing in All Major Database & Metadata, Citation Generator, Impact Factor:

7.95, ISSN: 2349-5162

UGC Approval: UGC and ISSN Approved - UGC Approved Journal No: 63975 | Link:

https://www.ugc.ac.in/journallist/subjectwisejurnallist.aspx?tid=MjM0OTUxNjI

=&&did=U2VhcmNoIGJ5IElTU04=

Registration ID: JETIR 186640 Paper ID : JETIRA006170

Title of Paper : AN EVALUATION OF THE DEVELOPMENT AND GROWTH

POTENTIAL OF CREDIT DEFAULT SWAP MARKET IN INDIA

Impact Factor : 7.95 (Calculate by Google Scholar)

DOI

Published in : Volume 5 | Issue 8 | 2018-08-16

Publication Date: 2018-08-16 Page No : 948-960

Published URL: http://www.jetir.org/view?paper=JETIRA006170

: Dr. Pranay Parashar, Dr. Sujit G. Metre

Thank you very much for publishing your article in JETIR. We would appreciate if you continue your support and keep sharing your knowledge by writing for our journal JETIR.



CiteSeer SRN .docstoc Google Scribd. OPEN OACCESS













International Journal of Emerging Technologies and Innovative Research (ISSN: 2349-5162)

www.jetir.org | editor@jetir.org | Impact Factor: 7.95 (Calculate by Google Scholar)